

Notice of References Cited

Application/Control No.

09/685,772

Applicant(s)/Patent Under
Reexamination
BLAESING-BANGERT ET AL.

Examiner

Michelle Nguyen

Art Unit

2851

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,609,285	09-1986	Samuels, Gerard	355/75
	B	US-4,549,843	10-1985	Jagusich et al.	414/416.01
	C	US-4,583,847	04-1986	Battig et al.	355/53
	D	US-4,655,594	04-1987	Wittekoek et al.	356/500
	E	US-5,786,897	07-1998	Ototake, Taro	356/511
	F	US-5,959,731	09-1999	Jones, Stephen H.	356/503
	G	US-5,894,056	04-1999	Kakizaki et al.	430/5
	H	US-5,608,773	03-1997	Korenaga et al.	378/34
	I	US-4,924,258	05-1990	Tsutsui, Shinji	355/53
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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FORM PTO-1449 U.S. Department of Commerce Patent & Trademark Office INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>	Attorney Docket No. 038664.49301US	Serial No. 09/685,772
	Applicant: Carola Blaesing-Bangert, et. al.	
	Filing Date October 11, 2000	Group 2851

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date (if appropriate)
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	TRANSLATION	
							Yes	No
	AK	EP1014030A1	6/28/00	Europe			Abstract	
	AL	WO 99/57508	11/11/99	WIPO				
	AM							
	AN							
	AO							
	AP							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	AQ	
	AR	
	AS	

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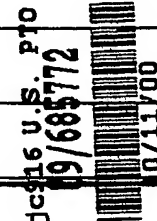
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Patent & Trademark OfficeAtty. Docket No.
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Serial No.

INFORMATION DISCLOSURE STATEMENT
(Use several sheets if necessary)Applicant
Carola BLAESING-BANGERT et al.Filing Date
October 11, 2000

Group

**U.S. PATENT DOCUMENTS**

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date (if appropriate)
<i>mw</i>	AA	5,539,521	7/23/96	Otokake et al.	<u> </u>	<u> </u>	
<i>mw</i>	AB	5,671,054	9/23/97	Iwasaki	<u> </u>	<u> </u>	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

		Document	Date	Country	Class	Sub-class	Translation Yes No
<i>mw</i>	AK	0 702 206	3/20/96	Europe	<u> </u>	<u> </u>	
	AL						
	AM						
	AN						
	AO						
	AP						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>mw</i>	AQ	SPIE, Vol. 3096-0277-786X/97, pp. 433-444 entitled "Advanced Mask Metrology System for up to 4Gbit DRAM" by Taro Ototake et al.					
	AR						
	AS						

EXAMINER

DATE CONSIDERED

7/30/03

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